

Large-Area Cryogenic Microcalorimeters (LAMCALs) for the DELight experiment

L. Hauswald¹, C. Jeup¹, F. Wagner¹, and S. Kempf^{1,2},

¹Institute of Micro- and Nanoelectronic Systems, Karlsruhe Institute of Technology, Hertzstraße 16 - Building 06.41, 76187 Karlsruhe

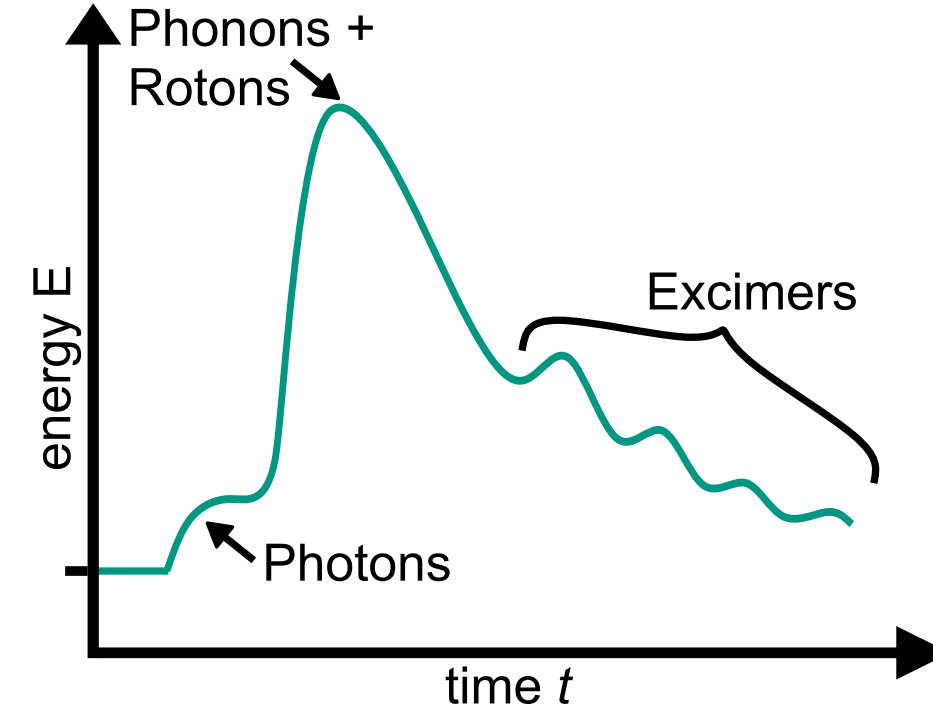
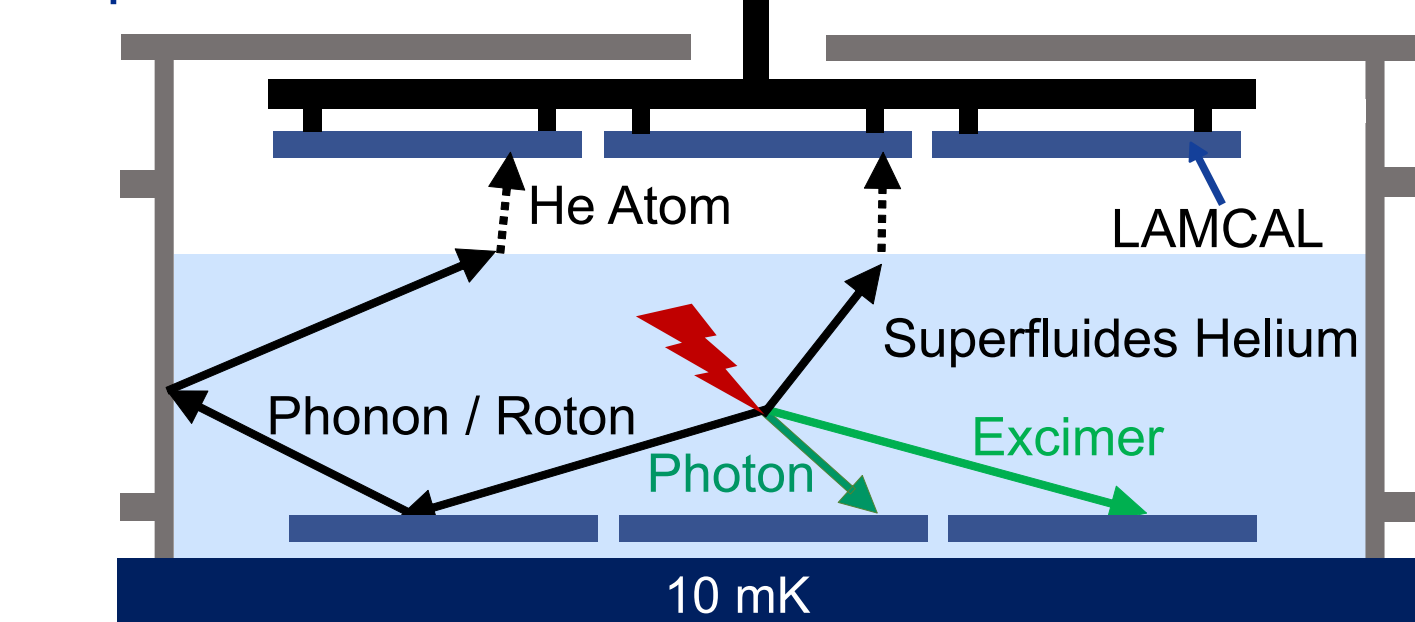
²Institute for Data Processing and Electronics, Karlsruhe Institute of Technology, Hermann-von-Helmholtz-Platz 1 - Building 242, 76344 Eggenstein-Leopoldshafen

DELight: Basics, Goals, and Challenges

Direct search Experiment for **Light** Dark Matter with Superfluid Helium (DELight):

- Detection of DM down to masses below 100 MeV with a nuclear recoil energy threshold of 20 eV
- Superfluid helium-4 as target material:
 - + sensitive to low DM masses
 - + radiopure and compact low-background target
 - + three signal channels
 - + liquid target (easily scalable)

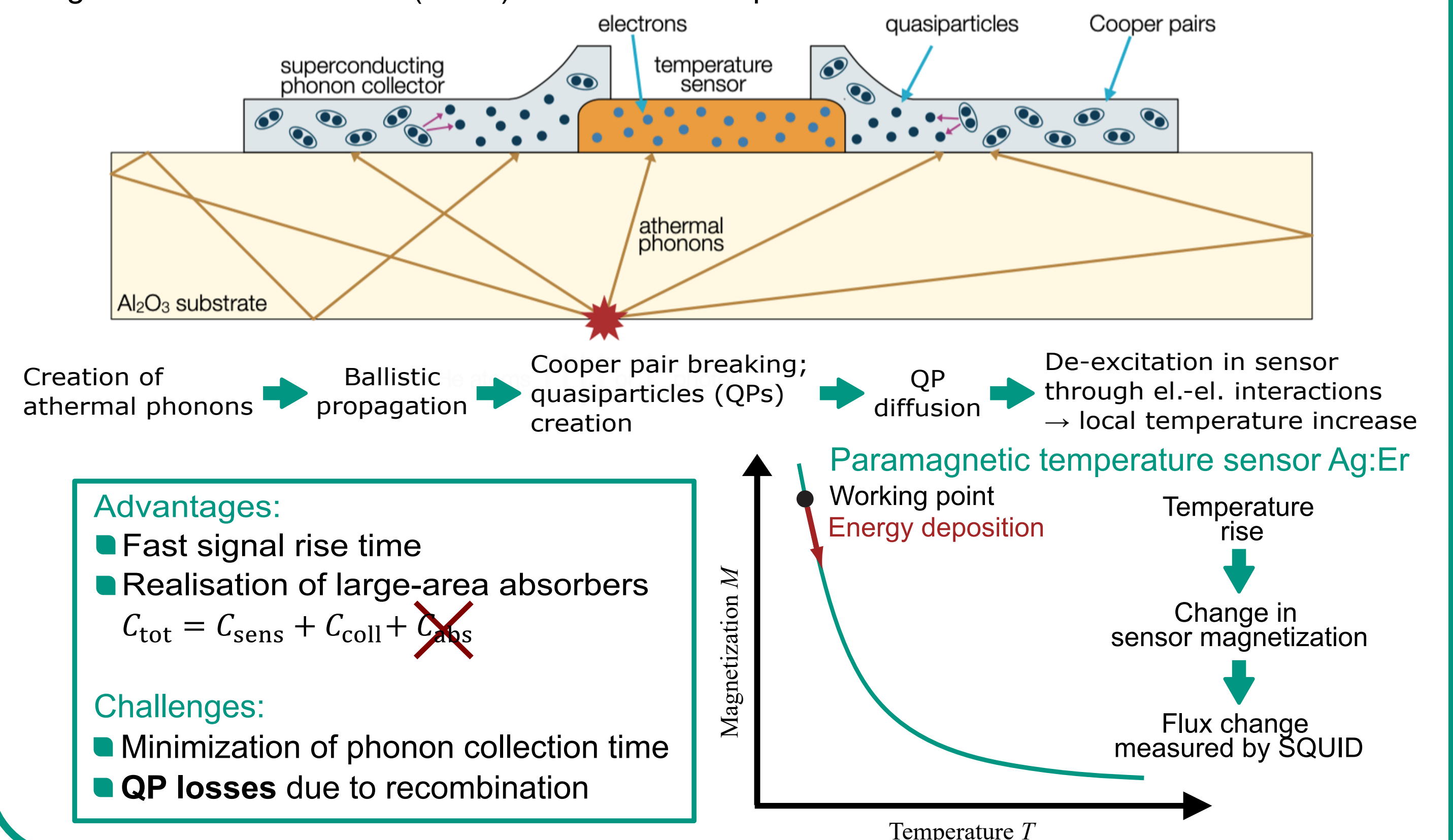
Superfluid Helium Cell



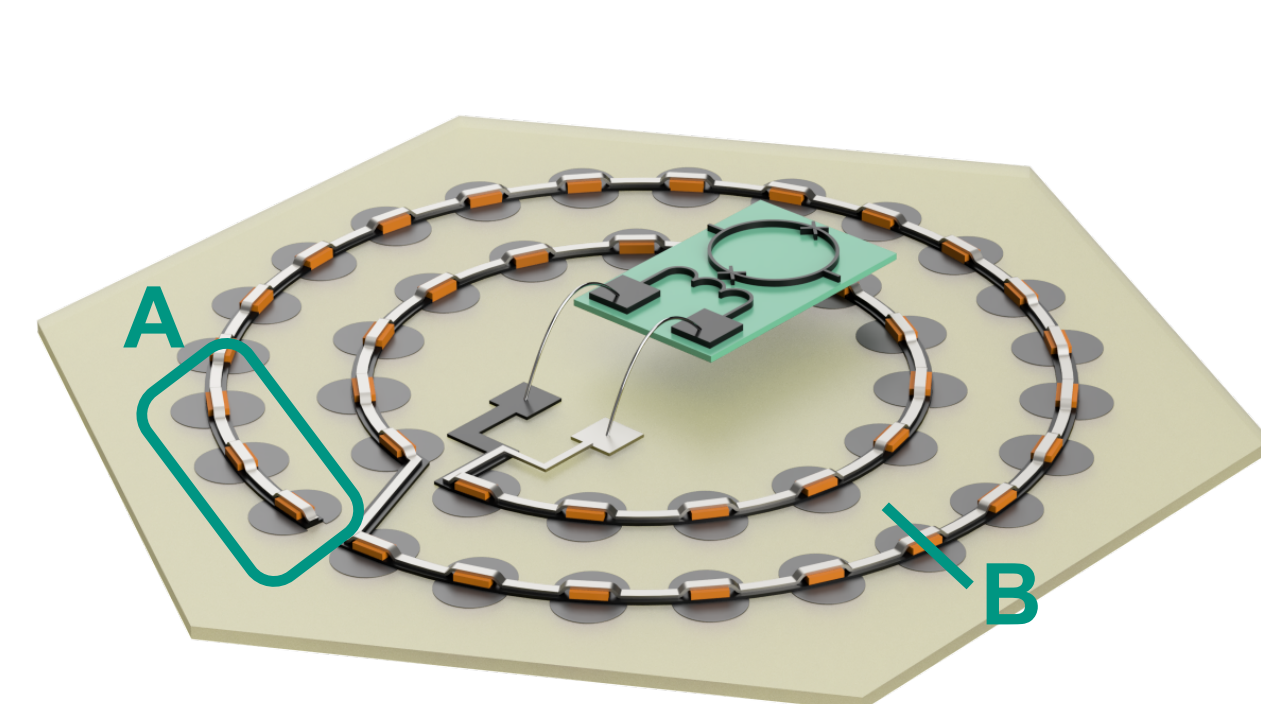
- Detector specifications for Phase I:
- Near-complete area coverage → large-area absorber
 - Excellent energy $\Delta E_{FWHM} \sim O(1-2 \text{ eV})$ and time resolution $\Delta t \sim O(1-10 \mu s)$ (10 % - 90 % signal rise time)
 - ➔ Large Area Microcalorimeters (LAMCALs)

Detector concept

Magnetic microcalorimeter (MMC) based athermal phonon detector:



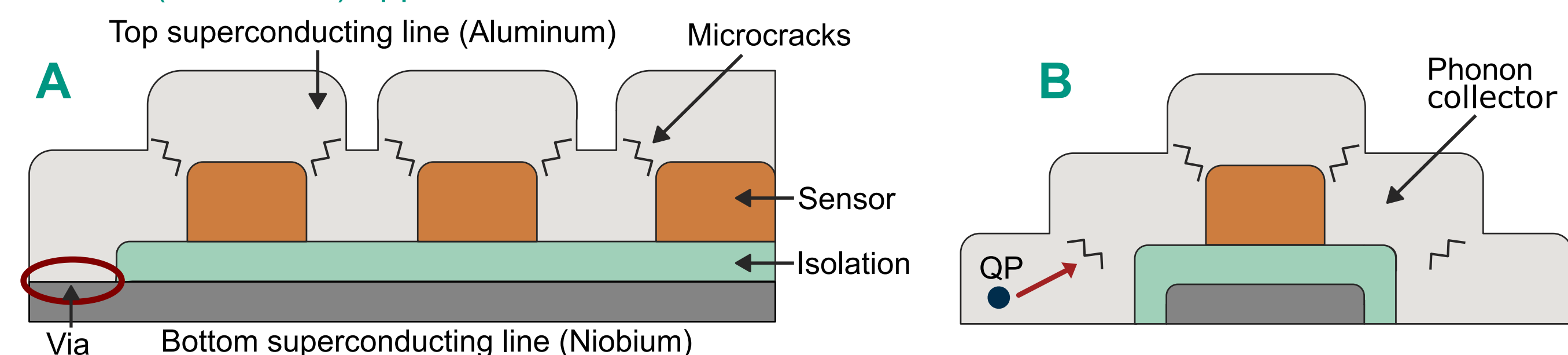
LAMCAL Development



Integrated detector design:
(Absorber + phonon collector + sensor on a single device)

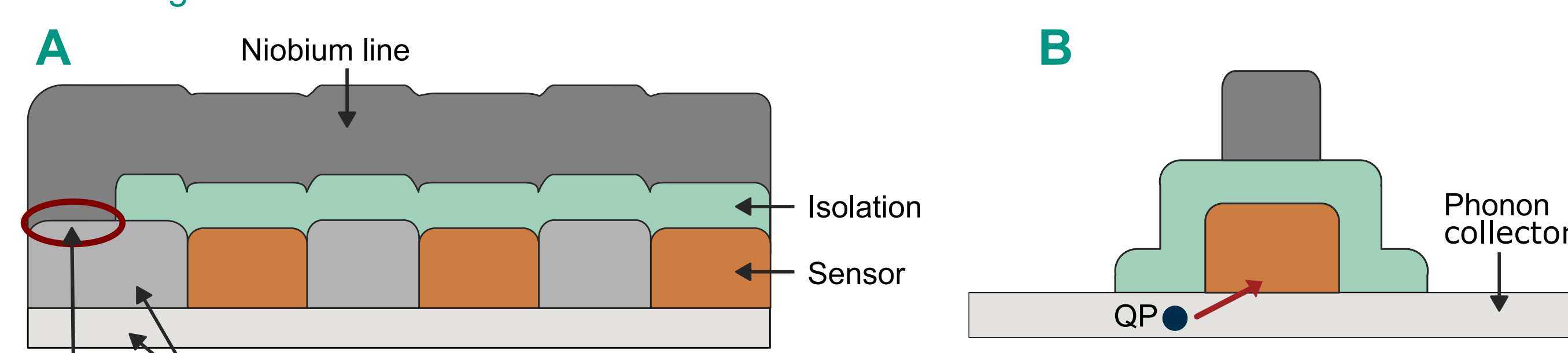
- Phonon collectors equally distributed among the wafer
- Minimizing phonon collection time
- Take into account the finite lifetime of the quasiparticles in the phonon collector
- Detector pieces connected via "sandwich" stripline
- Minimizing parasitic inductance

Intuitive ("standard") approach:



- Bends in the upper stripline may induce microcracks → reduces critical current
- Critical current reduction caused by the Nb/Al-via
- Microcracks affect quasiparticle diffusion toward the sensor

New design idea:

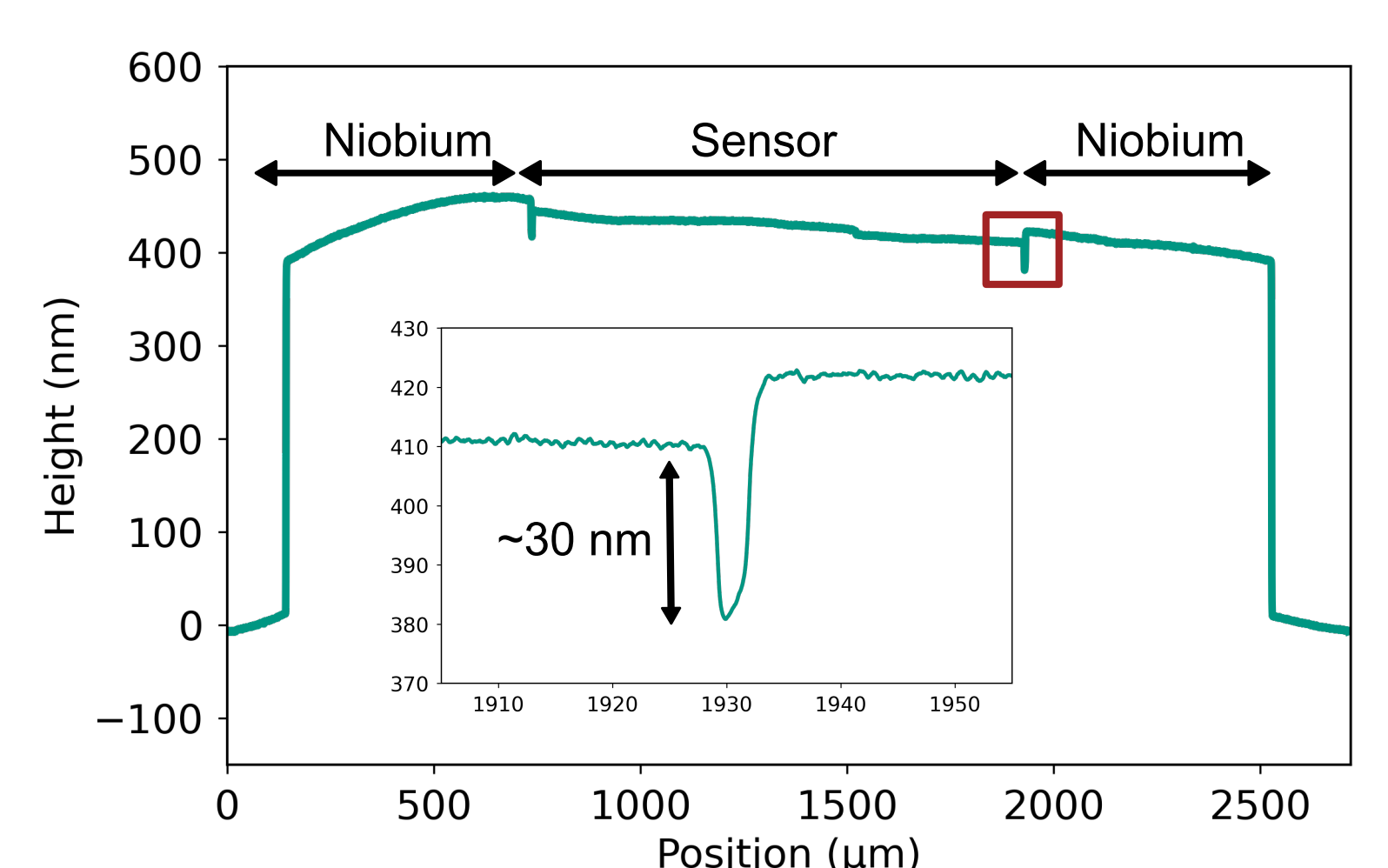
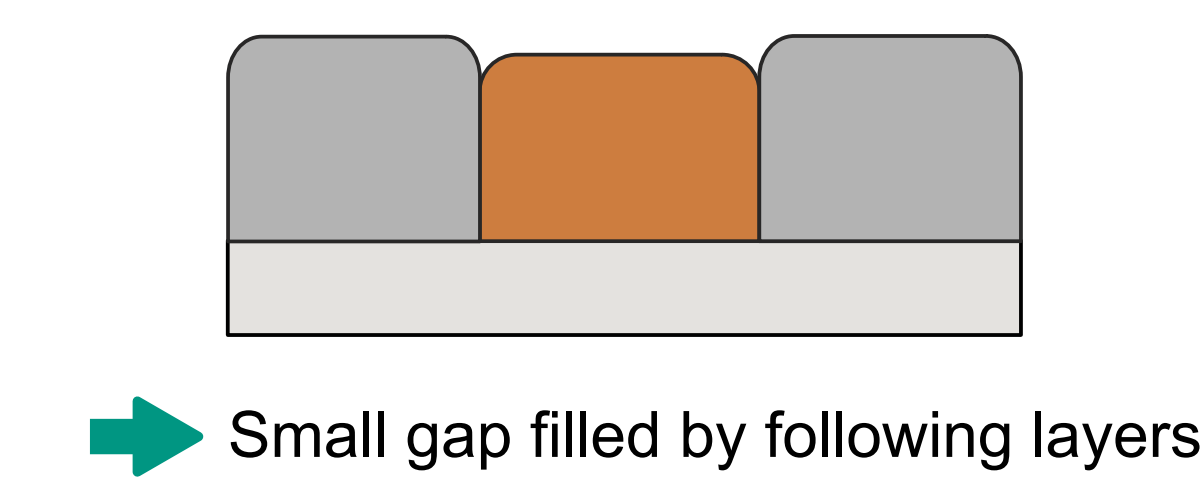


- Planarization of the top stripline → reducing microcracks
- In situ Aluminum/Niobium-Bilayer sputtering → no Al/Nb-via; less critical Nb/Nb-via
- Planar contact between sensor and phonon collector

Evidence of successful planarization:

- Measurement of the height profile

Structure:

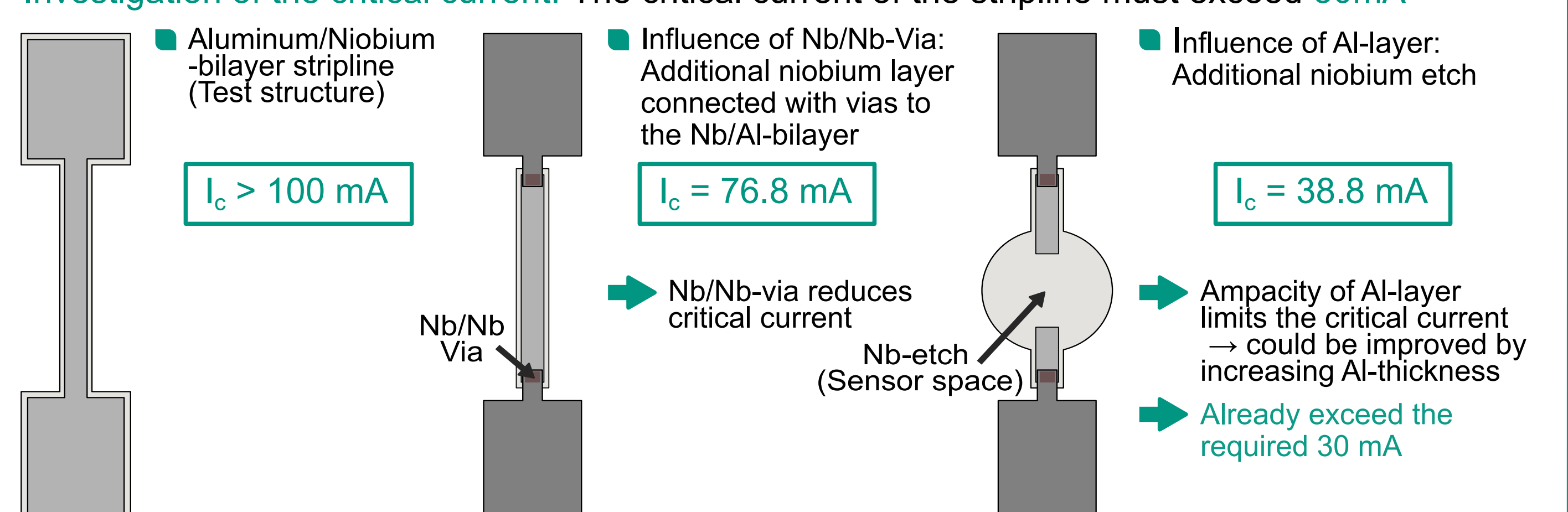


- Comparison room temperature resistance of planarized structure with different numbers of sensors with niobium stripline of same length

	Width w = 10 nm	Width w = 14 nm
4 Sensors	418 Ω	287 Ω
6 Sensors	—	282 Ω
8 Sensors	419 Ω	289 Ω
Test structure	416 Ω	283 Ω

- ➔ No significant resistance difference between planarized and test structures

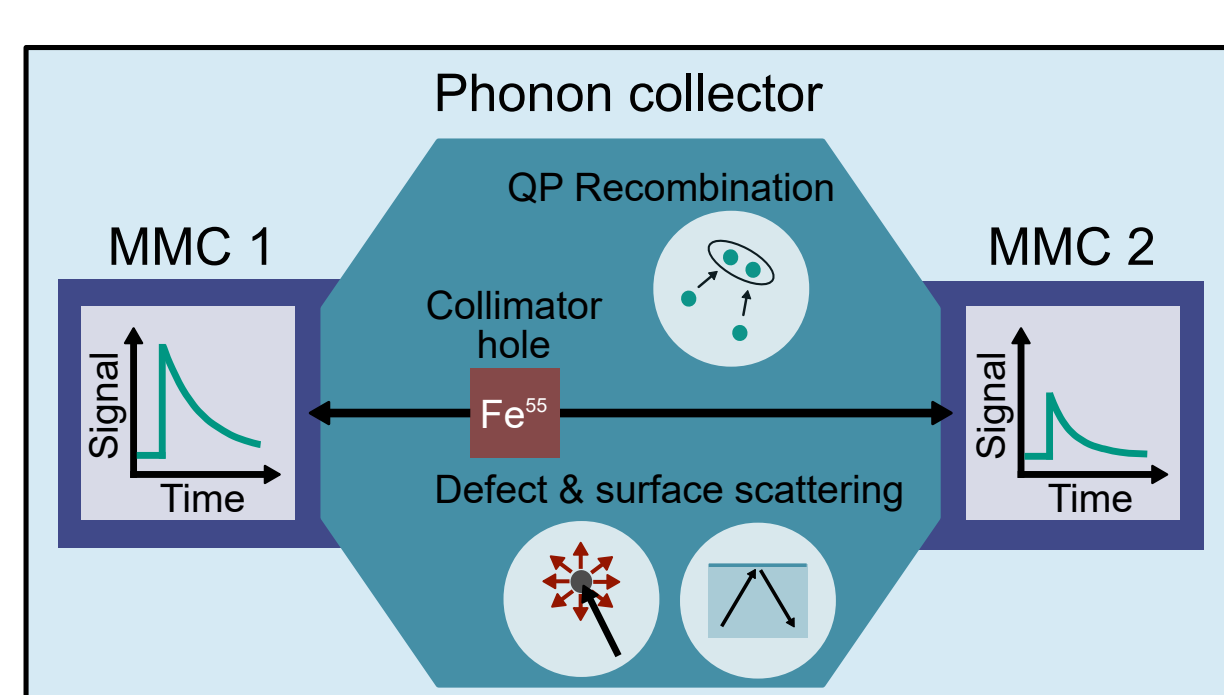
Investigation of the critical current: The critical current of the stripline must exceed 30mA



Quasiparticle lifetime experiment

Experiment motivated by CRESST

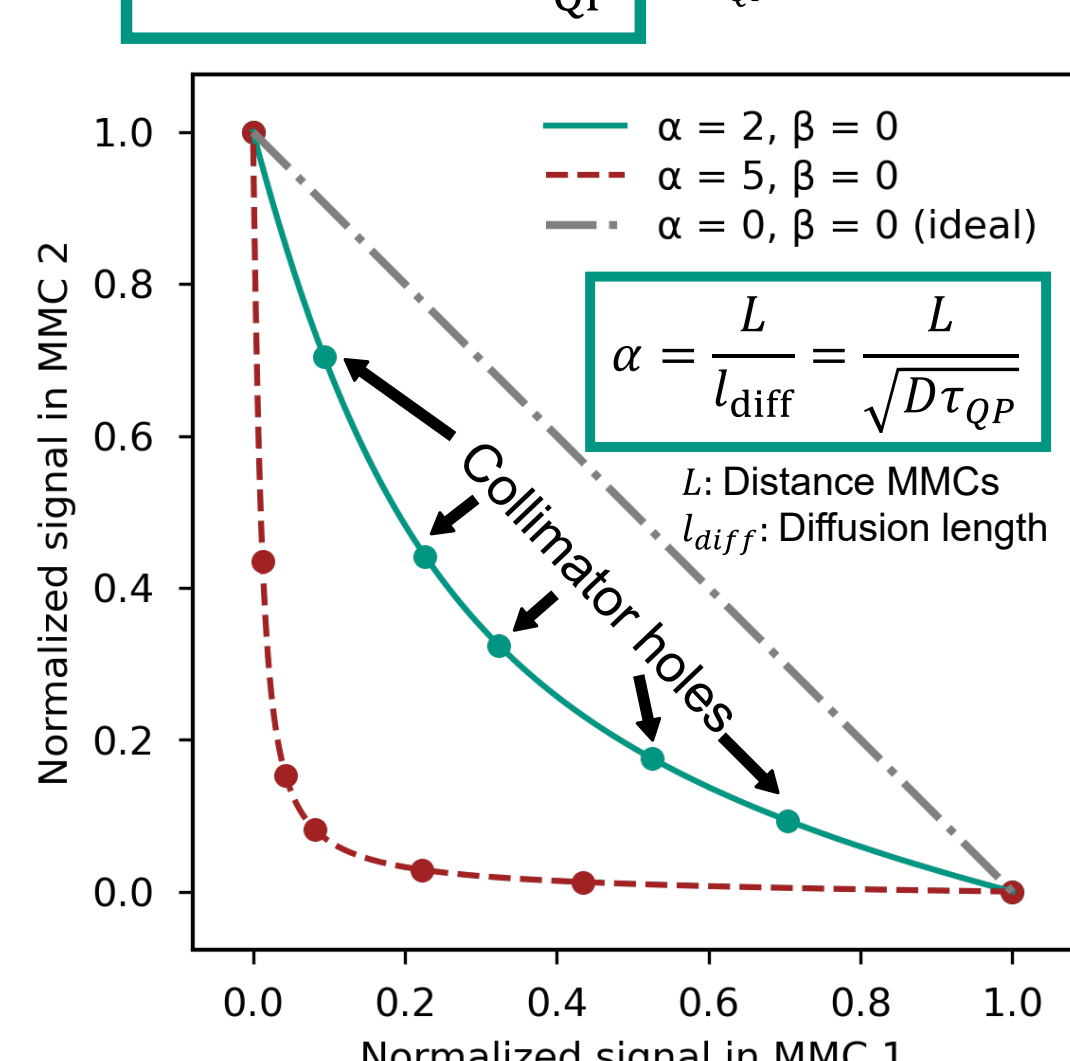
- Determination of diffusion length and quasiparticle lifetime
- Dependent on the choice of material and the quality of material
- Phonon collector geometry optimization



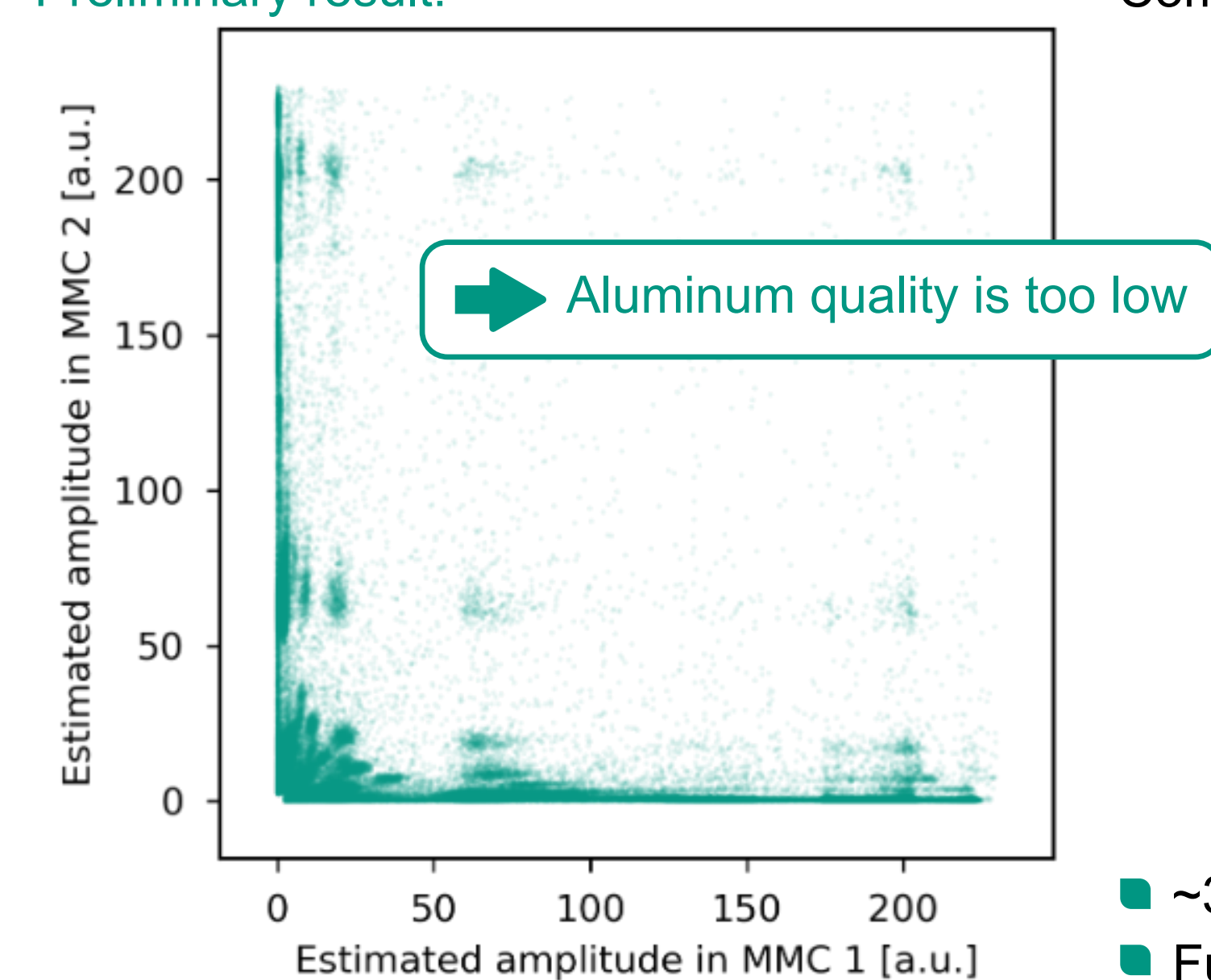
1D Diffusion equation

$$\frac{\delta n}{\delta t} = D \frac{\delta^2 n}{\delta x^2} - \frac{n}{\tau_{QP}}$$

n : QP density
 D : Diffusion constant
 τ_{QP} : QP lifetime



Preliminary result:



Comparison of different deposition techniques:

